

August 26, 1999

Federal Communications Commission Authorization and Evaluation Division 7435 Oakland Mills Road Columbia, MD 21046

Attention: Applications Examiner

Reference: FCC ID: HOLCL980CR

CIDCO Model CL980CR Cordless Telephone Base Unit

### Dear Examiner:

The following equipment authorization application is presented on behalf of CIDCO , Inc. for the certification of their Model CL980CR Cordless Telephone Base unit. Enclosed, please find complete data and documentation package demonstrating that this device complies with the technical requirements of 47 CFR, Part 15, Subpart C for an Intentional Radiator. The manufacturer seeks authorization under the

FCC ID: HOLCL980CR.

We look forward to an expeditious review of the report presented and a granting of the certification for CIDCO, Inc. If you have any questions or we can be of assistance, in this matter, please call us at (410) 354-3300.

Best regards,

Chris Harvey
EMC Laboratory Director,
MET Laboratories, Inc.

**Enclosures** 



MET Laboratories, Inc. Safety Certification - EMI - Telecom Environmental Simulation 914 WEST PATAPSCO AVENUE • BALTIMORE, MARYLAND 21230-3432 • PHONE (410) 354-3300 • FAX (410) 354-3313

## **ENGINEERING TEST REPORT**

in support of the Application for Grant of Equipment Authorization

**EQUIPMENT:** Model CL980CR Cordless Telephone Base Unit

FCC IDENTIFIER: HOLCL980CR

**SPECIFICATION:** 15.247(a) thru (e); 15.209(a).

Manufacturer: CIDCO, Inc.

220 Cochrane Circle Morgan Hill, CA 95037

**TESTING DATE(S):** 24, 25, 26 May, and 24 July 1999

MANUFACTURER'S

**REPRESENTATIVE:** Mr. Can Nguyen

## **ENGINEERING STATEMENT**

**I ATTEST:** the measurements shown in this report were made in accordance with the procedures indicated, and that the emissions from this equipment were found to be within the limits applicable. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them.

Alvin Ilaraia

Test Engineer, MET Laboratories, Inc.



## MODIFICATIONS STATEMENT

**I ATTEST:** that the product will be manufactured with all modifications for Part 15 compliance as submitted in this report. Modifications made during testing appear below:

1. No modifications were made to the EUT.

### 1.0 INTRODUCTION

The following test report is presented on behalf of the Applicant , as verification of the compliance of the CIDCO Direct Sequence, Spread -Spectrum Telephone Base unit , Model: CL980CR.

#### 2.0 TEST SITE

All testing was conducted at MET Laboratories, Inc., 914 West Patapsco Avenue, Baltimore, Maryland 21230-3432. Radiated emissions measurements were performed on a three-meter open air test site (OATS). A complete site description is on file with the FCC Laboratory Division as 31040/SIT/MET.

#### 3.0 TEST EQUIPMENT USED

Manufacturer	urer Equipment Calibration Due		Cal. Interval
Hewlett Packard	8593EM Spectrum Analyzer	12/1/99	annual
EMCO	Xwing Antenna 1145	4/1/00	annual
EMCO	Active Rod Antenna	2/15/00	annual
EMCO	Double Ridge Horn 3115	11/18/99	annual
EMCO	LISN 3825/2	4/3/00	annual

### **4.0 TEST CONFIGURATION**

The CIDCO Cordless Telephone Base model CL980CR, was configured with the Model: CL9HS Handset in accordance with the manufacturer's instructions and operated in a manner representative of the typical usage of the equipment. During testing of the EUT, the Base unit Model # CL980CR was manipulated within the confines of typical usage to maximize each emission.



## 6.0 TEST TYPE(S)

- 6.1 As required by §15.247(b) of CFR 47, *output power measurements* radiated measurements were performed to verify compliance with the conducted limit.
- 6.2 As required by §15.247(a)(2) of CFR 47, 6 dB bandwidth measurements were performed
- 6.3 As required by §15.247(e) of CFR 47, *processing gain* Measurements were not performed. Data is provided instead, by the spread spectrum chipset manufacturer
- 6.4 As required by §15.247(c)(1)& (c)(2) of CFR 47, out of band emissions measurements were performed.
- 6.5 As required by §15.247(d) of CFR 47, power density measurements were performed
- 6.6 As required by §15.107 of CFR 47, Line Conducted Emission measurements were performed

1.5m unshielded RJ-11 cable



## 7.0 EUT CONFIGURATION INFORMATION

**Equipment:** Base Station (900MHz Cordless Telephone)

Model #: CL980CR
Serial #: not provided
FCC ID: HOLCL980CR

**Equipment:** Handset (900MHz cordless Telephone)

Model #: CL9HS
Serial #: not provided
FCC ID: HOLCL9HS

Equipment: CO simulator

Model #: MET Labs

Serial #: n/a FCC ID #: n/a



# Photograph(s) of Radiated Emissions Test Configuration CIDCO Model CL980CR Cordless Telephone





## Photograph(s) of Line Conducted Emissions Test Configuration CIDCO Model CL980CR Cordless Telephone Base





**SUBJECT**: Peak Output Power **MET REPORT**: EM9544B

15.247(b) MFG: CIDCO FCC Part 15, Subpart C TESTED BY: Ken Bass

Intentional Radiator TEST DATE(S): 25 May 1999

EUT: CIDCO

**MODEL:** CL980CR (Telephone Base unit )

**TECHNICAL SPECIFICATION:** 15.247(b)

**CARRIER POWER:** Peak Output power was calculated through the following

means:

The raw reading from the analyzer was added to the cable loss and antenna factor (for the specific frequency of measurement). The final E-field strength limit is derived from the conversion of the power limit specified in FCC Part. 15.247(b) to V/m, considering a  $50\Omega$  system.

## Please see the attached plots

Handset/ Base	Freq (GHz)	Worst case Raw+ACF Reading (dBuV/m)	Dist (m)	Cbl/HPF/C on Loss (dB)	Pre amp (dB)	Corr level (dBµV/m)	Total (V/m)	Total watts
Base	914.76	109.50	3.0	2.8*	n/a	112.40	0.389	0.045

<sup>\* -</sup> Cable losses only. No High-pass filter (i.e. insertion loss) factors, etc., associated with measurement.

The Model CL980CR system results for the Base are provided as the highest level of the system. (Across the entire channel range)

Frequency Range (MHz)	Frequency (MHz)	Measured Signal (V/m)	E limit (V/m)	E margin (dB)
902-928	914.76	0.389	3.64	19.42



**SUBJECT:** 6 dB Bandwidth **MET REPORT:** EM9544B

15.247(a)(2) MFG: CIDCO FCC Part 15, Subpart C TESTED BY: Ken Bass

Intentional Radiator TEST DATE(S): 25 MAY 1999

EUT: CIDCO

MODEL: CL980CR Base Unit

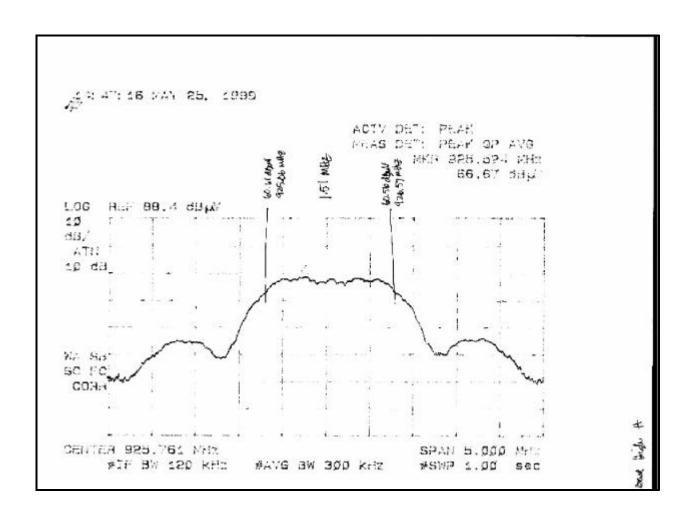
**TECHNICAL SPECIFICATION:** 15.247(a)(2)

Please see the attached plots

The 6 dB bandwidth was determined from the plot provided as follows:

EUT	Frequency (MHz)	6 dB Bandwidth (MHz)	
Base	925.761 (worst case)	1.51	







SUBJECT: Processing Gain MET REPORT: EM9544B

15.247(e) MFG: CIDCO
TESTED BY: Ken Book

FCC Part 15, Subpart C **TESTED BY:** Ken Bass Intentional Radiator **DATE:** (Pro

Intentional Radiator DATE: (Provided by chipset

EUT: CIDCO

MODEL: CL980CR (Telephone Base unit )

**TECHNICAL SPECIFICATION:** 15.247(e)

Processing Gain Measurements, per CFR 47, Part 15.247(e) were performed by the spread spectrum chipset manufacturer, Rockwell Semiconductor. Testing results as performed by Rockwell, have been included for reference and comparrison to the applicable limit.

Refer to the following 3 pages for tables, notes, and data, from the processing gain measurements provided by the spread spectrum chip manufacturer:



#### Introduction

## 1.1 Scope

This document is a Rockwell Semiconductor Systems (RSS) Engineering report. This document details the results of measurement of the processing gain of a DCT FFF phone.

#### 1.2 Intended Readers

The intended readers of this document are RSS marketing, application, engineering, test engineering, technical publication, and management personnel. This document is not intended for distribution outside of RSS.

#### 1.3 Reference Documents

This section lists documents that are referenced within or are materially relevant to this document.

Code of Federal Regulations, Title 47, Chapter 1, Part 15 Radio Frequency Devices (FCC)

### 1.4 Definitions

FCC	Federal Communications Commission
SNR	Signal to Noise Ratio
JSR	Jammer to Signal Ratio
CW	Continuous wave (jammer)
HS	Handset
BS	Basestation
DBPSK	Differential Binary Phase Shift Keying

Table 1: Definitions and Abbreviations

## 2. An Overview of the FCC Method for measuring Processing Gain

Two methods are specified for measuring processing gain by the FCC in 15.247 (e). The first method simply involves calculating the signal to ratio noise (SNR) with the spreading code switched on with the SNR when the spreading code is switched off. The difference between the two is the processing gain. The SNR is measured at the demodulated output of the receiver. In principle this an acceptable method to measure the processing gain of any direct sequence spread spectrum communication system, however, it does not take into consideration that the non-spread spectrum portion of the system may operate under the assumption that the signal being transmitted is a spread spectrum signal and when the spreading code is switched off the system may fail to operate or operate at greatly reduced efficiency. In either case the measurement of processing gain will be meaningless.

The second method specified by the FCC to measure processing gain is detailed in 15.247 (e)(1). This involves

August 24, 1999 - 12 - EM IU9544B



transmitting a CW jammer in the RF passband of the system and measuring the jammer to signal ratio (JSR) required to achieve a certain bit error rate. The choice of the actual value of the bit error rate is left up to the tester. The jammer is stepped in 50 kHz increments across the entire passband and in each case the JSR to achieve the desired bit error rate is measured. The JSR is measured at the RF input to the system under test. The lowest 20% of the JSR data (in dB) is discarded. The processing gain can then be calculated as follows:-

$$G_P = (S/N)_{theory} + (J/S)_{meas} + L_{system}$$

where  $G_p$  is the processing gain, the SNR is that theoretically predicted for the system under the test to achieve the desired bit error rate, the JSR is the lowest value (in dB) in the remaining data set and  $L_{sys}$  adjusts for non-ideal system losses.  $L_{sys}$  can not be greater than 2 dB.

## 3. Processing Gain Measurement Results

The following parameters were used in the test setup.

HS Tx power (dBm)	-1.9	
BS LNA gain (dB)	0	
Channel attenuation (dB)	-50	
Test system losses (signal) (dB)	-11.75	-4.05 dB (system), -6 dB (signal combiner), -1.7 dB (2 cables)
Test system losses (jammer) (dB)	-12.85	-12 dB (signal combiner), -0.85 dB (cable)

Table 2: Test Setup Parameters

The following measurement results were taken at the basestation. The desired bit error rate was set at 10<sup>-3</sup>.

Jammer Frequency	BER (BS)	Received jammer	Received signal	Jammer/Signal ratio
913.80	9.4×10 <sup>-4</sup>	-59.55	-63.65	4.1
913.85	9.6×10 <sup>-4</sup>	-57.95	-63.65	5.7
913.90	9.6×10 <sup>-4</sup>	-60.15	-63.65	3.5
913.95	9.6×10 <sup>-4</sup>	-64.25	-63.65	-0.6
914.00	1.1×10 <sup>-3</sup>	-61.55	-63.65	2.1
914.05	9.8×10 <sup>-4</sup>	-61.55	-63.65	2.1
914.10	1.1×10 <sup>-3</sup>	-61.95	-63.65	1.7
914.15	9.2×10 <sup>-4</sup>	-62.85	-63.65	0.8
914.20	1.0×10 <sup>-3</sup>	-59.85	-63.65	3.8
914.25	1.0×10 <sup>-3</sup>	-61.15	-63.65	2.5
914.30	1.1×10 <sup>-3</sup>	-62.05	-63.65	1.6
914.35	1.0×10 <sup>-3</sup>	-57.65	-63.65	6.0
914.40	1.1×10 <sup>-3</sup>	-55.65	-63.65	8.0
914.45	1.0×10 <sup>-3</sup>	-49.35	-63.65	14.3
914.50	1.1×10 <sup>-3</sup>	-59.25	-63.65	4.4
914.55	1.0×10 <sup>-3</sup>	-62.35	-63.65	1.3
914.60	9.7×10 <sup>-4</sup>	-59.05	-63.65	4.6
914.65	1.0×10 <sup>-3</sup>	-61.05	-63.65	2.6
914.70	1.1×10 <sup>-3</sup>	-62.55	-63.65	1.1
914.75	9.0×10 <sup>-4</sup>	-61.95	-63.65	1.7
914.80	1.0×10 <sup>-3</sup>	-61.05	-63.65	2.6
914.85	9.9×10 <sup>-4</sup>	-62.35	-63.65	1.3
914.90	1.1x10 <sup>-3</sup>	-64.05	-63.65	-0.4



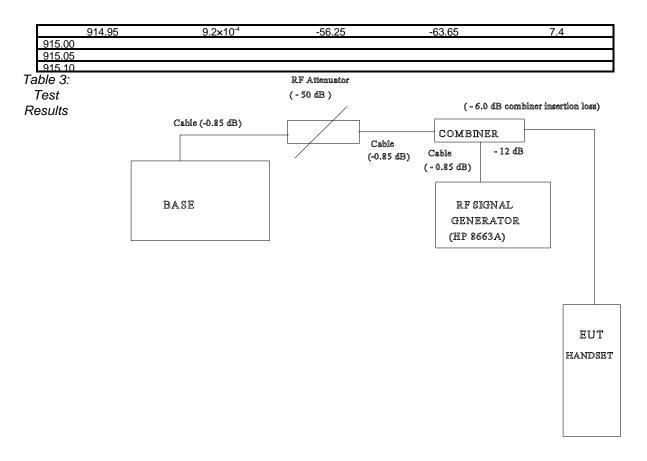


Figure 1: Test Setup

For DBPSK at 10<sup>-3</sup> bit error rate the required SNR is 8.0 dB. Using the results above and the data in the table below the processing gain is calculated to be 11.3 dB.

required SNR (dB)	8.0
system losses (dB)	2.0
J/S ratio at 80% point (dB)	1.30
FCC Processing gain (dB)	11.3

Table 4: Processing Gain Calculation data



### 4. Conclusions

The result measured for processing gain of 11.3 dB is close to the actual processing gain due to a 12 chip spreading code of

 $10 \times \log_{10}(12) = 10.8 \text{ dB}$ 

SUBJECT: Spurious Emissions MET REPORT: EM9544B

15.247(c)(paragraphs 1 & 2) **MFG:** CIDCO FCC Part 15, Subpart C **TESTED BY:** Ken Bass

Intentional Radiator TEST DATE(S): 25 May

1999

**EUT:** CIDCO

**MODEL:** CL980CR (Telephone Base unit)

**TECHNICAL SPECIFICATION:** 15.247(c)(paragraphs 1 & 2)

Test data is presented on the following plot @ 100 kHz RBW:

The marker was placed on the highest emission inside the band and the marker recorded.

w/ RBW = 100 kHz, the highest emission within the band of operation was found to be = 112.05 dBuV. Therefore;

all spurs harmonics must be 112.40 - 20 dB = 92.40 dBuV.

**spurs** that fall **in Restricted Band** (per 15.205) must meet the **limits of 15.209** (i.e. 54 dBuV):



Freq (GHz)	Ant orient H/V	Raw Reading (dBµV)	Ant Factor (dB/m)	Cbl/HPF/ Conn Loss (dB)	d (m)	d corr (dB)	Pre-Amp Gain <sup>1</sup> (dB)	Corr. Level (dBµV/m)	Limits (dBµV/m)	Comments
0.192	Н	22.21	9.6	1.39	3.0	0.0	0.0	33.2	43.50	Restricted band
0.192	V	21.76	9.6	1.39	3.0	0.0	0.0	32.75	43.50	Restricted band
1.829	Н	17.16	26.5	3.0	1.0	- 9.54	34.50	2.62	92.40	spur
1.829	V	41.87	26.5	3.0	1.0	- 9.54	34.50	27.33	92.40	spur
2.743	Н	•	29.1	4.2	1.0	-9.54	34.60	-	54.00	Restricted band ( signal below noise floor )
2.743	V	32.4	29.3	4.2	1.0	- 9.54	34.60	21.86	54.00	Restricted band
3.685	I	1	31.5	5.2	1.0	- 9.54	34.50	-	54.00	Restricted band ( signal below noise floor )
3.685	V	22.88	31.2	5.2	1.0	- 9.54	34.50	16.67	54.00	Restricted band
4.572	Н	-	-	9.0	1.0	-9.54	34.50	-	54.00	Restricted band ( signal below noise floor )
4.572	V	27.89	32.8	9.0	1.0	-9.54	34.50	25.75	54.00	Restricted band
5.487	Н	-	-	7.0	1.0	-9.54	34.50	-	92.40	Spur
5.487	V	27.27	35.1	7.0	1.0	-9.54	34.50	25.73	92.40	Spur

<sup>\*</sup>Note - All levels taken above, were with VBW set to 10 Hz to simulate an average measurement. These levels are pulsed in nature, but HAVE NOT been adjusted for the peak-average correction factor.



**SUBJECT:** Transmitted Power Spectural **MET REPORT:** EM9544B

Density

15.247(d) MFG CIDCO
FCC Part 15, Subpart C TESTED BY: Ken Bass
Intentional Radiator TEST DATE(S): 24 JUL 1999

EUT: CIDCO MODEL: CL980CR

**TECHNICAL SPECIFICATION:** 15.247(d)

Power density limit is stated as +8 dBm.

Test data is presented on the plots following this section:

**Base**: Model: CL980CR (Telephone base unit)

The largest value found within a 3 kHz bandwidth for the Base unit of the EUT, was found to be:

For the Base : -37.0 dBm + 23.4 dB = -13.6 dBm or  $93.5 \text{ dB}\mu\text{V/m}$  (or 0.058 V/m).

(Note: were 23.40 dB is Aantenna Factor for antenna used.)

Solving the above for power density output using the equation:  $P_D = (\underline{E} \cdot \underline{d})^2$ 30G

Where; E = 0.058 V/m, d = 3.0 m, and G = 1.0 for isotropic antenna

Therefore;  $P_D = (0.058 * 3)^2 / 30(1) = 0.001009 W \text{ or } 1 \text{ mW}$ 

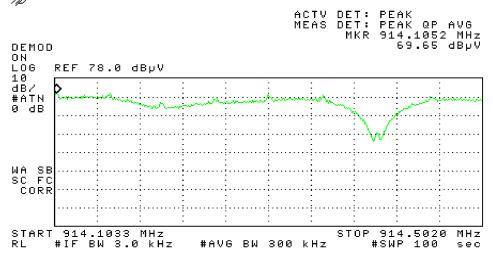
 $P_D = 1 \text{ m W} = 0.0 \text{ dBm}_{\text{meas}}$ 

 $P_D$  Limit = +8 dBm

Please see the following 5 plots on the next 3 pages.

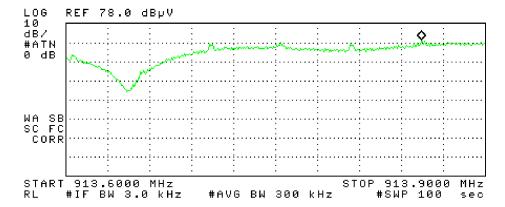


16:39:38 JUL 24, 1999



16:29:21 JUL 24, 1999

ACTV DET: PEAK
MEAS DET: PEAK QP AVG
MKR 913.8543 MHz
69.14 dBpV





DEMOD ON LOG

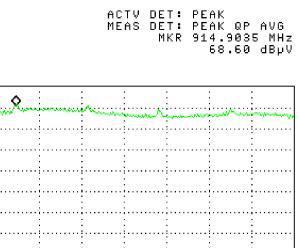
10 dB/

#ATN 0 dB

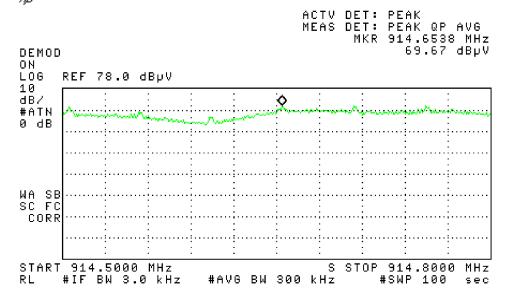
WA SB SC FC CORR

17:01:21 JUL 24, 1999

REF 78.0 dBpV

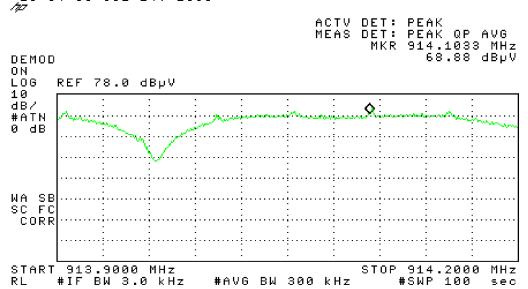


16:43:19 JUL 24, 1999





16:34:03 JUL 24, 1999 伊





**SUBJECT:** Conducted Emissions MET REPORT: EM9544B

**Neutral Side** 

MFG: CIDCO FCC Part 15, Subpart C **TESTED BY:** Ken Bass

TEST DATE(S): Intentional Radiator 26 May 1999

EUT: **CIDCO** 

CL980CR (Telephone Base unit) MODEL:

## **TECHNICAL SPECIFICATION:**

Equipment meets the specifications of Part 15.107(a)

## SUMMARY — 3 Worst-Case Emissions

Frequency (MHZ)	Quasi-Peak Level (dBµV)	Limit (dBµV)
27.35	24.00	47.95
29.19	25.83	47.95
16.87	21.67	47.95

EM



**SUBJECT:** Conducted Emissions

Phase Side

FCC Part 15, Subpart C

Intentional Radiator

**MET REPORT:** EM9544B

MFG: CIDCO

TESTED BY: Ken Bass

**TEST DATE(S)**: 26 May 1999

EUT: CIDCO

**MODEL:** CL980CR (Telephone Base unit)

**TECHNICAL SPECIFICATION:** 15.107(a)

**LIMITS:**  $0.45 - 1.705 \text{ MHZ} : 250 \mu \text{V} (47.9 \text{ dB}\mu\text{V})$ 

Equipment meets the specifications of Part 15.107(a)

SUMMARY — 3 Worst-Case Emissions

Frequency (MHz)	Level (dBµV)	Limit (dBμV)
3.82	34.60	47.95
9.50	39.06	47.95
3.23	35.87	47.95